Applicant(s)/Patent Under Application/Control No. Reexamination 10/738,399 AHN et al. Notice of References Cited Art Unit Examiner Page 1 of 1 2818 Lee, Calvin **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 438/437 08-1990 Lee et al. US-4,952,524 Α 438/435 11-2000 Wu et al. US-6,150,238 В 430/314 US-2003/0124465 07-2003 Lee et al. С US-D US-Ε F US-G US-US-Н US-US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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